



SPORTON LAB.

Certificate No: C930908

CERTIFICATE

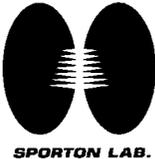
● Equipment Under Test : RAID Subsystem

Model No. : RAID-500XX (X=0~9, A~Z)

Applicant : Advantech Co., Ltd.

Fl. 4, No. 108-3, Ming-Chuan Road,

Shing-Tien City, Taipei, Taiwan, R.O.C.



CERTIFY THAT:

THE MEASUREMENTS SHOWN IN THIS TEST REPORT WERE MADE IN ACCORDANCE WITH THE PROCEDURES GIVEN IN EUROPEAN COUNCIL DIRECTIVE 89/336/EEC. THE EQUIPMENT WAS PASSED THE TEST PERFORMED ACCORDING TO EUROPEAN STANDARD EN 55022/A1 *Class A*, EN 61000-3-2, EN 61000-3-3, and EN 50082-2 (EN 61000-4-2, ENV 50140, EN 61000-4-4, EN 61000-4-5, ENV 50141, EN 61000-4-11).

THE TEST WAS CARRIED OUT ON March 23, 1999 AT SPORTON INTERNATIONAL INC. LAB.

Lenore Chang
March 23, 1999

Lenore Chang
President

CE TEST REPORT

according to

**European Standard EN 55022:1994/A1:1995 Class A,
EN 61000-3-2:1995, EN 61000-3-3:1995 and
EN 50082-2:1995 (EN 61000-4-2:1995, ENV 50140:1993, EN 61000-4-4:1995,
EN 61000-4-5:1995, ENV 50141:1993, EN 61000-4-11:1994)**

EQUIPMENT : RAID Subsystem

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APPLICANT : **Advantech Co., Ltd.**

Fl. 4, No. 108-3, Ming-Chuan Road,
Shing-Tien City, Taipei, Taiwan, R.O.C.

- The test result refers exclusively to the test presented test model / sample.
- Without the written authorization of the test lab., the Test Report may not be copied.

SPORTON INTERNATIONAL INC.

6F, No. 106, Hsin Tai Wu Rd., Sec. 1, Hsi Chih, Taipei Hsien, Taiwan, R.O.C.

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CERTIFICATE NO. : C930908

CERTIFICATE OF COMPLIANCE

according to

**European Standard EN 55022:1994/A1:1995 Class A,
EN 61000-3-2:1995, EN 61000-3-3:1995 and
EN 50082-2:1995 (EN 61000-4-2:1995, ENV 50140:1993, EN 61000-4-4:1995,
EN 61000-4-5:1995, ENV 50141:1993, EN 61000-4-11:1994)**

EQUIPMENT : RAID Subsystem

MODEL NO. : RAID-500XX (X=0~9, A~Z)

APPLICANT : **Advantech Co., Ltd.**

Fl. 4, No. 108-3, Ming-Chuan Road,
Shing-Tien City, Taipei, Taiwan, R.O.C.

I HEREBY CERTIFY THAT :

The measurements shown in this test report were made in accordance with the procedures given in **EUROPEAN COUNCIL DIRECTIVE 89/336/EEC**. The equipment was **passed** the test performed according to **EUROPEAN STANDARD EN 55022:1994/A1:1995 Class A, EN 61000-3-2:1995, EN 61000-3-3:1995 and EN 50082-2:1995 (EN 61000-4-2:1995, ENV 50140:1993, EN 61000-4-4:1995, EN 61000-4-5:1995, ENV 50141:1993, EN 61000-4-11:1994)**.

The test was carried out on **March 23, 1998** at **SPORTON INTERNATIONAL INC. LAB.**



Lenore Chang

President

SPORTON INTERNATIONAL INC.

6F, No. 106, Hsin Tai Wu Rd., Sec. 1, Hsi Chih, Taipei Hsien, Taiwan, R.O.C.

1. GENERAL DESCRIPTION OF EQUIPMENT UNDER TEST

1.1. APPLICANT

Advantech Co., Ltd.

Fl. 4, No. 108-3, Ming-Chuan Road,
Shing-Tien City, Taipei, Taiwan, R.O.C.

1.2. MANUFACTURER

Same as 1.1

1.3. BASIC DESCRIPTION OF EQUIPMENT UNDER TEST

EQUIPMENT : RAID Subsystem
MODEL NO. : RAID-500XX (X=0~9, A~Z)
TRADE NAME : Advantech
SCSI DATA CABLE : Shielded, 1m
POWER SUPPLY TYPE : Switching
POWER CORD : Non-shielded, 1.8m, 3pin

1.4. FEATURE OF EQUIPMENT UNDER TEST

- Supports RAID levels 0, 1(0+1), 3 or 5
- Ultra-Wide SCSI interface, optional Ultra2 and Fibre channels.
- 4 SCSI channels on Base module, additional upgrade module (up to 8 channels)
- Channels Interface :
 - Base module : Four 68-pin, Ultra-Wide single-ended
 - Upgrade boards : Four upgrade boards are available for additional channels.
- Up to 8 logical drives with different RAID levels ; up to 32 LUN per SCSI ID (multiple SCSI ID per channel are supported)
- All SCSI (Fibre) channels configurable as either host channels or drive channels
- Supports cache memory size up to 128 MB with 72-pin SIMM, also supports EDO RAM for improved bandwidth
- GUI and RS-232 terminal interfaces for RAID management
- CPU temperature, controller voltage monitoring

2. TEST CONFIGURATION OF EQUIPMENT UNDER TEST

2.1. TEST MANNER

- a. The SONY monitor, DELL keyboard, ACEEX modem, LOGITECH RS232 mouse and EUT were connected to the ADVANTECH IPC for EMI test. During testing, the interface cables and equipment positions were varied according to European Standard EN 55022.
- b. The HP monitor, DELL keyboard, ACEEX modem, LOGITECH RS232 mouse and EUT were connected to the ADVANTECH IPC for Harmonics, Flicker and EMS test.

2.2. DESCRIPTION OF TEST SYSTEM

<EMI>

Support Device 1. --- MONITOR (SONY)

FCC ID : AK8GDM17SE2T
Model No. : GDM-17SE2T
Serial No. : SP1009
Data Cable : Shielded, 360 degree via metal backshells, 1.7m
Power Supply Type : Switching
Power Cord : Non-shielded

Support Device 2. --- KEYBOARD (DELL)

FCC ID : GYUM92SK
Model No. : AT101 (DE8M)
Serial No. : SP1021
Data Cable : Shielded, 360 degree via metal backshells, 1.9m

Support Device 3. -- RS232 MOUSE (LOGITECH)

FCC ID : DZL210365
Model No. : M-M35
Serial No. : SP1032
Data Cable : Non-shielded, 1.9m

Support Device 4. -- MODEM (ACEEX)

FCC ID : IFAXDM1414
Model No. : DM1414
Power Supply Type : Linear, AC Adapter
Power Cord : Non-shielded
Serial No. : SP1045
Data Cable : Shielded, 360 degree via metal backshells, 1.15m

Support Device 5. --- P.C. (ADVANTECH)

Model No. : IPC-6908
Serial No. : SP1005
Data Cable : Shielded

<EMS>

Support Device 1. --- MONITOR (HP)

FCC ID : ACJ93312116
Model No. : D2807A
Serial No. : SP1010
Data Cable : Shielded, 360 degree via metal backshells, 1.7m
Power Supply Type : Switching

Support Device 2. --- KEYBOARD (DELL)

FCC ID : GYUM92SK
Model No. : AT101 (DE8M)
Serial No. : SP1021
Data Cable : Shielded, 360 degree via metal backshells, 1.9m

Support Device 3. -- RS232 MOUSE (LOGITECH)

FCC ID : DZL210365
Model No. : M-M35
Serial No. : SP1032
Data Cable : Non-shielded, 1.9m

Support Device 4. -- MODEM (ACEEX)

FCC ID : IFAXDM1414
Model No. : DM1414
Power Supply Type : Linear, AC Adapter
Power Cord : Non-shielded
Serial No. : SP1045
Data Cable : Shielded, 360 degree via metal backshells, 1.15m

Support Device 5. --- P.C. (ADVANTECH)

Model No. : IPC-6908
Serial No. : SP1005
Data Cable : Shielded

3. TEST SOFTWARE

An executive program, HDD.BAT (It is a Hard Disk copy program which included Read & Copy Mode) under WIN NT4.0, was used as the test software.

4. GENERAL INFORMATION OF TEST

4.1. TEST FACILITY

This test was carried out by SPORTON INTERNATIONAL INC.

Test Site Location : No. 30-1, Lin 6, Diing-Fwu Tsuen, Lin-Kou-Hsiang,
Taipei Hsien, Taiwan, R.O.C.

TEL : 886-2-2601-1640

FAX : 886-2-2601-1695

4.2. STANDARD FOR METHODS OF MEASUREMENT

EMI Test (conduction and radiation) : European Standard EN 55022 Class A.

Harmonics Test : European Standard EN 61000-3-2.

Voltage fluctuations Test : European Standard EN 61000-3-3.

EMS Test (ESD, RS, EFT and SURGE) : European Standard EN 50082-2.

(ESD: EN61000-4-2, RS: ENV50140, EFT: EN 61000-4-4, SURGE: EN 61000-4-5, CS: ENV 50141
, DIPS: EN 61000-4-11)

4.3. TEST IN COMPLIANCE WITH

EMI Test (conduction and radiation) : European Standard EN 55022 Class A.

Harmonics Test : European Standard EN 61000-3-2.

Voltage fluctuations Test : European Standard EN 61000-3-3.

EMS Test (ESD, RS, EFT and SURGE) : European Standard EN 50082-2.

(ESD: EN61000-4-2, RS: ENV50140, EFT: EN 61000-4-4, SURGE: EN 61000-4-5, CS: ENV 50141
, DIPS: EN 61000-4-11)

4.4. FREQUENCY RANGE INVESTIGATED

- a. Conducted emission test: from 150 KHz to 30 MHz
- b. Radiated emission test: from 30 MHz to 1000 MHz
- c. Radio frequency electromagnetic field immunity test : from 27 MHz to 1000 MHz.

4.5. TEST DISTANCE

The test distance of radiated emission test from antenna to EUT is 10 M.

The test distance of radio frequency electromagnetic field immunity test from antenna to EUT is 3 M.

5. TEST OF CONDUCTED POWERLINE

Conducted Emissions were measured from 150 KHz to 30 MHz with a bandwidth of 9 KHz on the 230 VAC power and return leads of the EUT according to the methods defined in European Standard EN 55022 Clause 9. The EUT was placed on a nonmetallic stand in a shielded room 0.8 meters above the ground plane as shown in Figure 5-3. The interface cables and equipment positioning were varied within limits of reasonable applications to determine the position producing maximum conducted emissions.

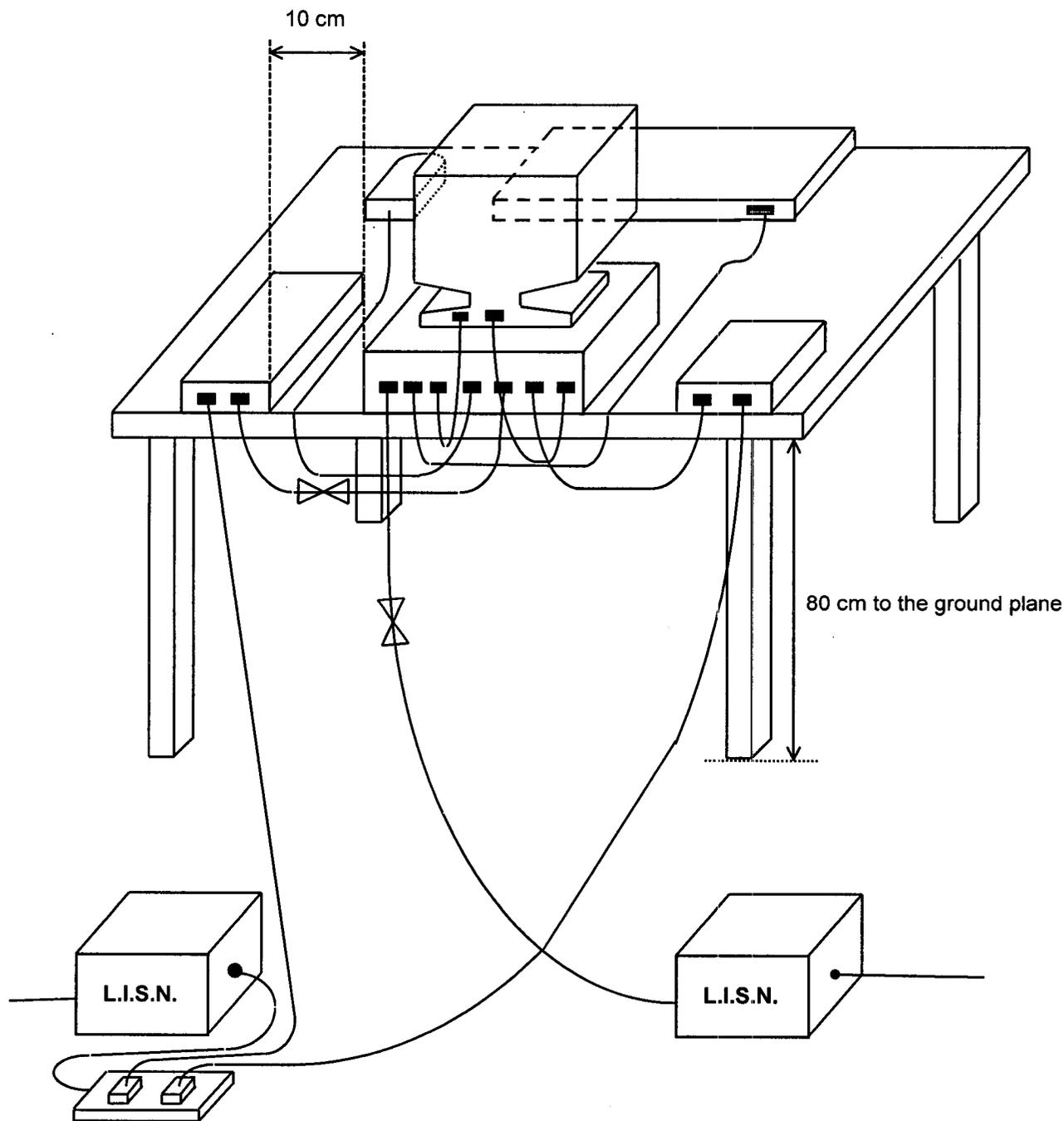
5.1. DESCRIPTION OF MAJOR TEST INSTRUMENTS

- Test Receiver (HP 8591EM)
 - Attenuation 0 dB
 - Start Frequency 0.15 MHz
 - Stop Frequency 30 MHz
 - Step MHz 0.007 MHz
 - IF Bandwidth 9 KHz

5.2. TEST PROCEDURES

- a. The EUT was placed on a desk 0.8 meters height from the metal ground plane and 0.4 meter from the conducting wall of the shielding room and it was kept at least 0.8 meters from any other grounded conducting surface.
- b. Connect EUT to the power mains through a line impedance stabilization network (LISN).
- c. All the support units are connect to the other LISN.
- d. The LISN provides 50 ohm coupling impedance for the measuring instrument.
- e. The CISPR states that a 50 ohm , 50 microhenry LISN should be used.
- f. Both sides of AC line were checked for maximum conducted interference.
- g. The frequency range from 150 KHz to 30 MHz was searched.
- h. Set the test-receiver system to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- i. If the emission level of the EUT in peak mode was 6 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 6 dB margin will be retested one by one using the quasi-peak method and/or average methods and reported.

5.3. TYPICAL TEST SETUP LAYOUT OF CONDUCTED POWERLINE

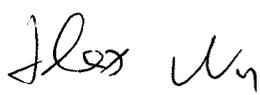


5.4. TEST RESULT OF AC POWERLINE CONDUCTED EMISSION

- Equipment meets the technical specifications of EN 55022 (1994)
- Frequency Range of Test : from 0.15 MHz to 30 MHz
- Temperature : 21°C
- Relative Humidity : 63% RH
- Test Mode : ***Power Right***
- Test Date : March 19, 1998

The Conducted Emission test was passed at **Line 13.72 MHz / 34.00 dBuV.**

Frequency (MHz)	Line or Neutral	Meter Reading				Limits				Margin	
		Q.P. (dBuV)	A.V. (dBuV)	Q.P. (uV)	A.V. (uV)	Q.P. (dBuV)	A.V. (dBuV)	Q.P. (uV)	A.V. (uV)	Q.P. (dB)	A.V. (dB)
0.160	L	38.10	31.90	80.35	39.36	79.00	66.00	8912.51	1995.26	-40.90	-34.10
0.220	L	37.70	34.40	76.74	52.48	79.00	66.00	8912.51	1995.26	-41.30	-31.60
13.720	L	34.00	31.10	50.12	35.89	73.00	60.00	4466.84	1000.00	-39.00	-28.90
0.160	N	37.00	31.50	70.79	37.58	79.00	66.00	8912.51	1995.26	-42.00	-34.50
0.270	N	37.30	35.50	73.28	59.57	79.00	66.00	8912.51	1995.26	-41.70	-30.50
0.650	N	30.90	26.70	35.08	21.63	73.00	60.00	4466.84	1000.00	-42.10	-33.30

Test Engineer : 

 Alex Wu

5.4.1. TEST RESULT OF AC POWERLINE CONDUCTED EMISSION

- Equipment meets the technical specifications of EN 55022 (1994)
- Frequency Range of Test : from 0.15 MHz to 30 MHz
- Temperature : 21°C
- Relative Humidity : 63% RH
- Test Mode : ***Power Left***
- Test Date : March 19, 1998

The Conducted Emission test was passed at **Line 0.22 MHz / 39.40 dBuV.**

Frequency (MHz)	Line or Neutral	Meter Reading				Limits				Margin	
		Q.P. (dBuV)	A.V. (dBuV)	Q.P. (uV)	A.V. (uV)	Q.P. (dBuV)	A.V. (dBuV)	Q.P. (uV)	A.V. (uV)	Q.P. (dB)	A.V. (dB)
0.150	L	39.10	25.00	90.16	17.78	79.00	66.00	8912.51	1995.26	-39.90	-41.00
0.220	L	39.40	36.60	93.33	67.61	79.00	66.00	8912.51	1995.26	-39.60	-29.40
0.650	L	30.50	27.90	33.50	24.83	73.00	60.00	4466.84	1000.00	-42.50	-32.10
13.600	L	33.10	28.50	45.19	26.61	73.00	60.00	4466.84	1000.00	-39.90	-31.50
0.170	N	36.70	23.00	68.39	14.13	79.00	66.00	8912.51	1995.26	-42.30	-43.00
13.550	N	32.70	27.50	43.15	23.71	73.00	60.00	4466.84	1000.00	-40.30	-32.50

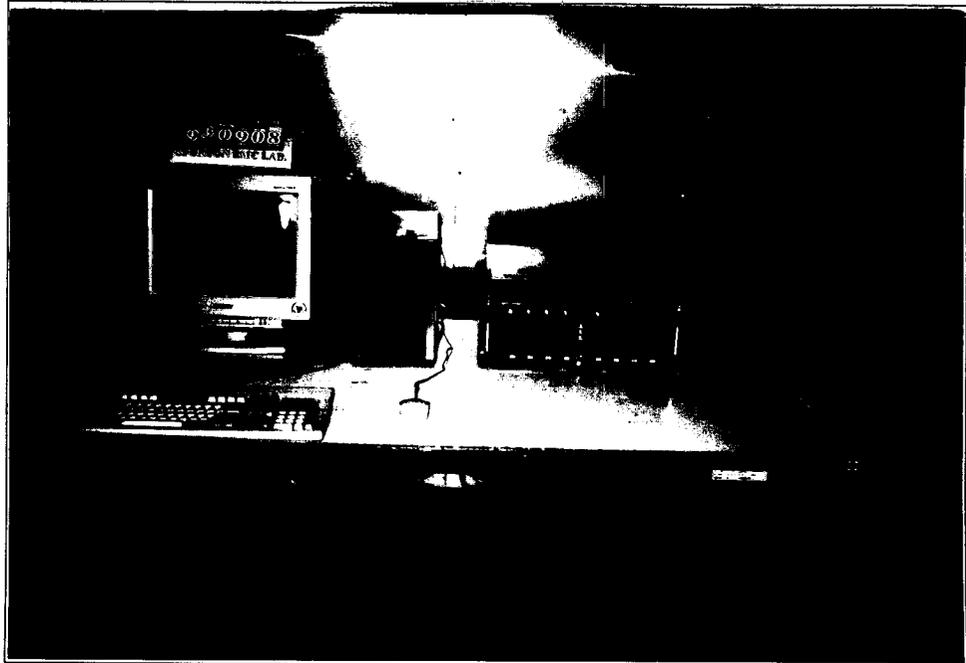
Test Engineer :



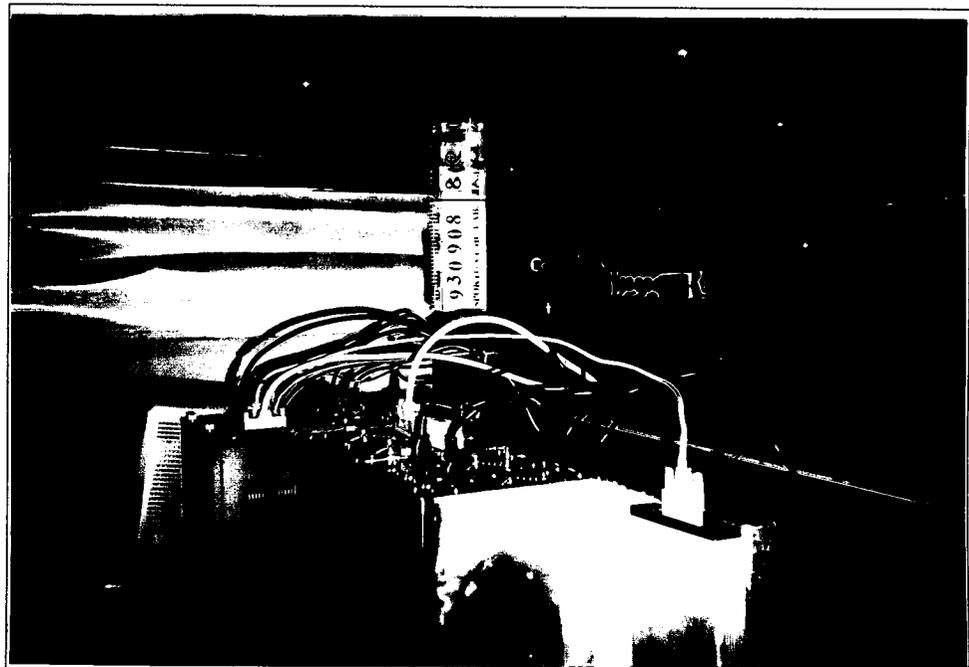
 Alex Wu

5.5. PHOTOGRAPHS OF CONDUCTED EMISSION TEST CONFIGURATION

FRONT VIEW



REAR VIEW



6. TEST OF RADIATED EMISSION

Radiated emissions from 30 MHz to 1000 MHz were measured with a bandwidth of 120 KHz according to the methods defines in European Standard EN 55022, Clause 10. The EUT was placed on a nonmetallic stand in the open-field site, 0.8 meter above the ground plane, as shown in Figure 6-3. The interface cables and equipment positions were varied within limits of reasonable applications to determine the positions producing maximum radiated emissions.

6.1. DESCRIPTION OF MAJOR TEST INSTRUMENTS

- Amplifier (HP 8447D)
 - Attenuation 0 dB
 - RF Gain 25 dB
 - Signal Input 0.1 MHz to 1.3 GHz

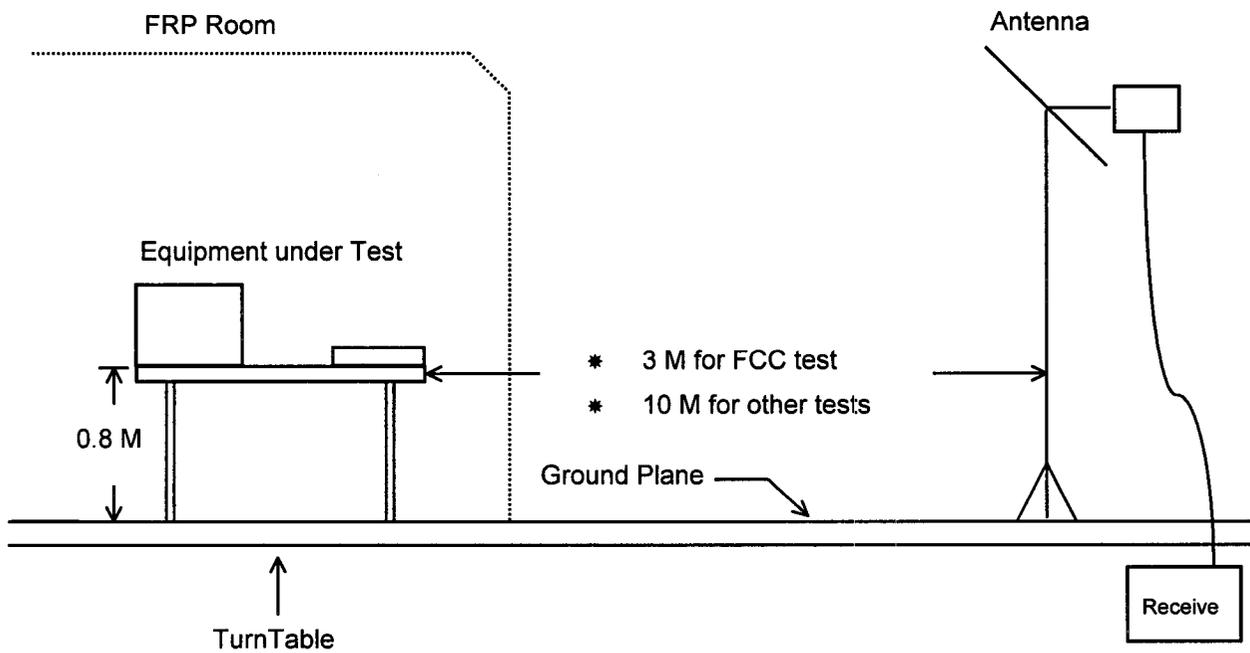
- Spectrum Analyzer (HP 8568B)
 - Attenuation 0 dB
 - Start Frequency 30 MHz
 - Stop Frequency 1000 MHz
 - Resolution Bandwidth 1 MHz
 - Video Bandwidth 1 MHz
 - Signal Input 100 Hz to 1.5 GHz

- Quasi-Peak Adapter (HP 85650A)
 - Resolution Bandwidth 120 KHz
 - Frequency Band 30 MHz to 1 GHz
 - Quasi-Peak Detector ON for Quasi-Peak Mode
OFF for Peak Mode

6.2. TEST PROCEDURES

- a. The EUT was placed on a rotatable table top 0.8 meter above ground.
- b. The EUT was set 10 meters from the interference receiving antenna which was mounted on the top of a variable height antenna tower.
- c. The table was rotated 360 degrees to determine the position of the highest radiation.
- d. The antenna is a half wave dipole and its height is varied between one meter and four meters above ground to find the maximum value of the field strength both horizontal polarization and vertical polarization of the antenna are set to make the measurement.
- e. For each suspected emission the EUT was arranged to its worst case and then tune the antenna tower (from 1 M to 4 M) and turn table (from 0 degree to 360 degrees) to find the maximum reading.
- f. Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- g. If the emission level of the EUT in peak mode was 6 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 6 dB margin will be repeated one by one using the quasi-peak method and reported.

6.3. TYPICAL TEST SETUP LAYOUT OF RADIATED EMISSION



6.4. TEST RESULT OF RADIATED EMISSION

- Equipment meets the technical specifications of EN 55022 (1994)
- Frequency Range of Test : from 30 MHz to 1000 MHz
- Test Distance : 10 M
- Temperature : 21°C
- Relative Humidity : 63 % RH
- Test Date : Mar. 22, 1999
- Emission level (dBuV/m) = 20 log Emission level (uV/m)
- Corrected Reading : Antenna Factor + Cable Loss + Reading = Emission

The Radiated Emission test was passed at

Vertical 134.100 MHz / 36.89 dBuV ,

Antenna Height 1.0 Meter , Turntable Degree 120°.

Frequency (MHz)	Polarity	Antenna Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	(dBuV/m)	Limits (uV/m)	Emission (dBuV/m)	Level (uV/m)	Margin (dB)
34.800	V	15.51	0.70	17.80	40.00	100	34.01	50.18	-5.99
79.600	V	7.08	0.80	28.72	40.00	100	36.60	67.61	-3.40
109.000	V	11.52	1.10	23.70	40.00	100	36.32	65.46	-3.68
134.100	V	11.38	1.31	24.20	40.00	100	36.89	69.90	-3.11
267.200	V	11.99	1.64	29.39	47.00	224	43.02	141.58	-3.98
34.275	H	15.74	0.70	17.80	40.00	100	34.24	51.52	-5.76

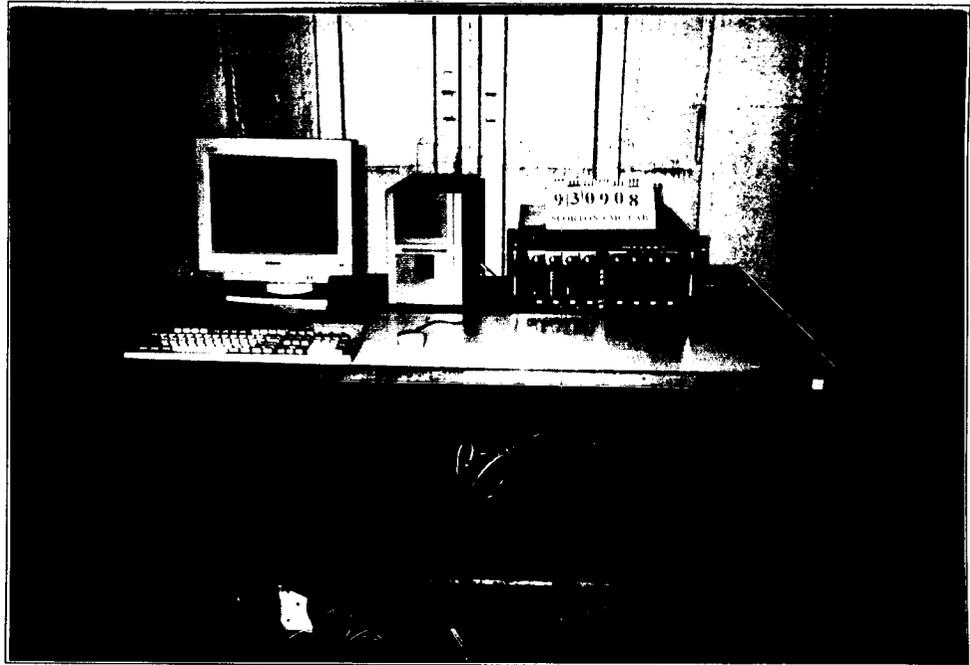
Test Engineer :

William Lee

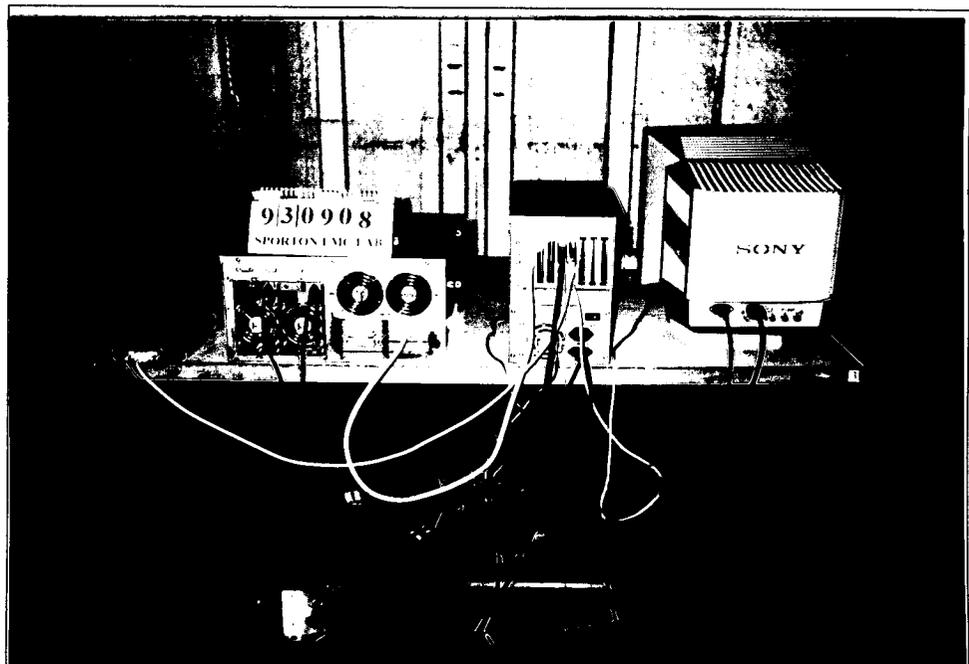
 William Lee

6.5. PHOTOGRAPHS OF RADIATED EMISSION TEST CONFIGURATION

FRONT VIEW



REAR VIEW



7. HARMONICS TEST

7.1. STANDARD

- Product Standard : EN 61000-3-2 (1995)

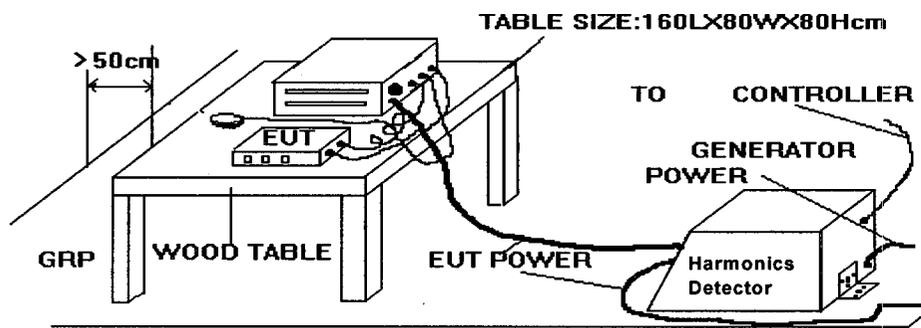
7.2. TEST PROCEDURE

The measured values of the harmonics components of the input current, including line current and neutral current, shall be compared with the limits given in Clause 4.

7.3. TEST EQUIPMENT SETTINGS :

- Line Voltage : 230V
- Line Frequency : 50Hz
- Device Class : A
- Current Measurement Range : High
- Measurement Delay : 10.0 seconds
- Test Duration : 2.0 minutes
- Class determination Pre-test Duration : 10.0 seconds

7.4. TEST SETUP



7.5. HARMONICS TEST

7.5.1. TEST DATA OF HARMONICS

- FINAL TEST RESULT : **PASS**
- Fundamental Current : 0.194 A
- Real Power : 42.50W
- Power Factor : 0.484
- Percent in Envelope : 100 %
- Temperature : 24 °C
- Relative Humidity : 54% RH
- Test Date : Mar. 22, 1999

Harmonic Number	Standard Limit (A rms)	Max. Span Values (A rms)	Harmonic Number	Standard Limit (A rms)	Max. Span Values (A rms)
1	Fund	0.2214	21	0.1070	0.0190
2	1.0800	0.0030	22	0.0840	0.0005
3	2.3000	0.2042	23	0.0980	0.0145
4	0.4300	0.0023	24	0.0770	0.0005
5	1.1400	0.1883	25	0.0900	0.0120
6	0.3000	0.0023	26	0.0710	0.0004
7	0.7700	0.1660	27	0.0830	0.0096
8	0.2300	0.0022	28	0.0660	0.0004
9	0.4000	0.1410	29	0.0780	0.0066
10	0.1840	0.0014	30	0.0610	0.0004
11	0.3300	0.1126	31	0.0730	0.0040
12	0.1530	0.0011	32	0.0580	0.0003
13	0.2100	0.0857	33	0.0680	0.0030
14	0.1310	0.0009	34	0.0540	0.0003
15	0.1500	0.0617	35	0.0640	0.0042
16	0.1150	0.0009	36	0.0510	0.0003
17	0.1320	0.0419	37	0.0610	0.0044
18	0.1020	0.0009	38	0.0480	0.0003
19	0.1180	0.0276	39	0.0580	0.0038
20	0.0920	0.0007	40	0.0460	0.0003

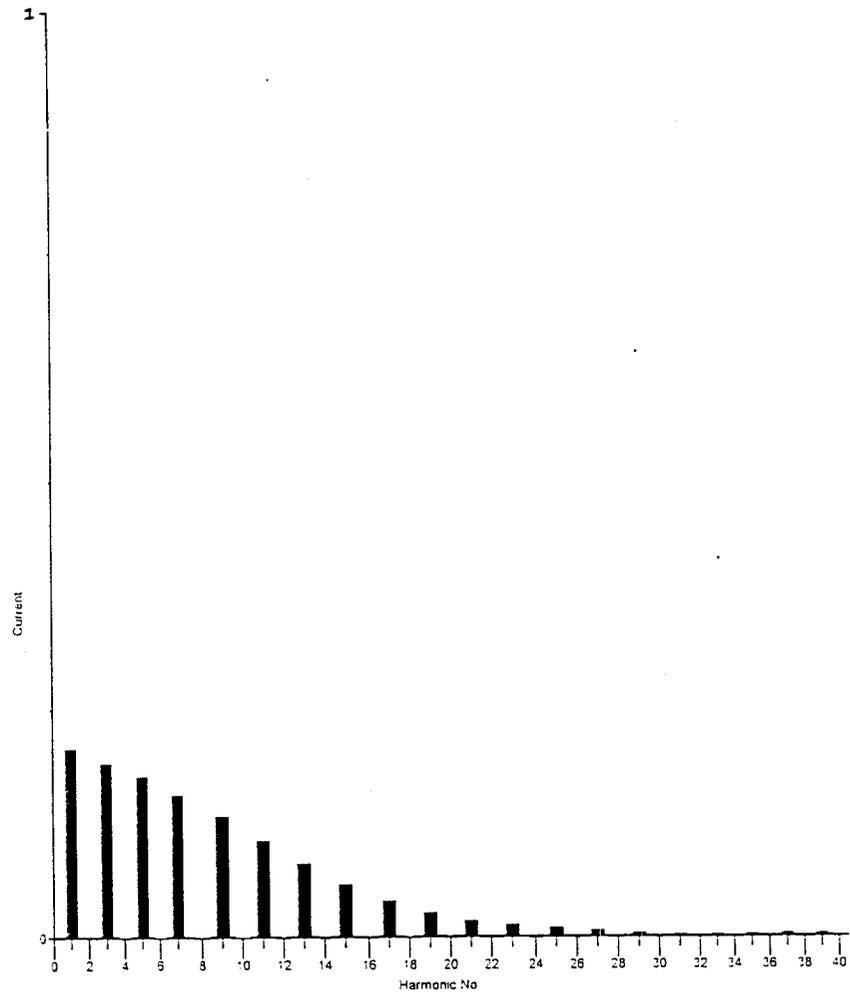
Test Engineer :

Bruce Huang

 Bruce Huang

7.5.2. TEST GRAPH OF HARMONICS

Harmonics



8. VOLTAGE FLUCTUATIONS TEST

8.1. STANDARD

- Product Standard : EN 61000-3-3 (1995)

8.2. TEST PROCEDURE

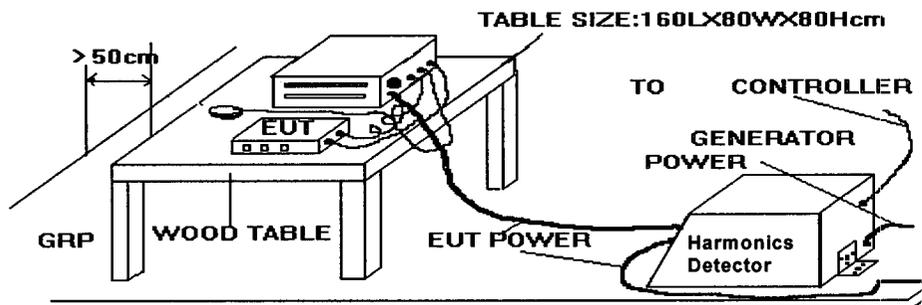
The equipment shall be tested under the conditions of **Clause 5**.

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance. The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of $\pm 8\%$ is achieved during the whole assessment procedure.

8.3. TEST EQUIPMENT SETTINGS :

- Line Voltage : 230 V
- Line Frequency : 50 Hz
- Measurement Delay : 10.0 seconds
- Pst Integration Time : 10 minutes
- Pst Integration Periods : 1
- Test Duration : 00:10:00 minutes

8.4. TEST SETUP



8.5. TEST RESULT OF VOLTAGE FLUCTUATION AND FLICKER TEST

8.5.1. TEST DATA OF VOLTAGE FLUCTUATION AND FLICKER

- FINAL TEST RESULT : **PASS**
- Temperature : 24 °C
- Relative Humidity : 54% RH
- Test Date : Mar. 22, 1999

	Pst	Plt	Dc (%)	Dmax (%)	Dt (%)
Reading	0.070	0	0	0	0
Limit	0.65	1.0	3.0	4.0	3.0

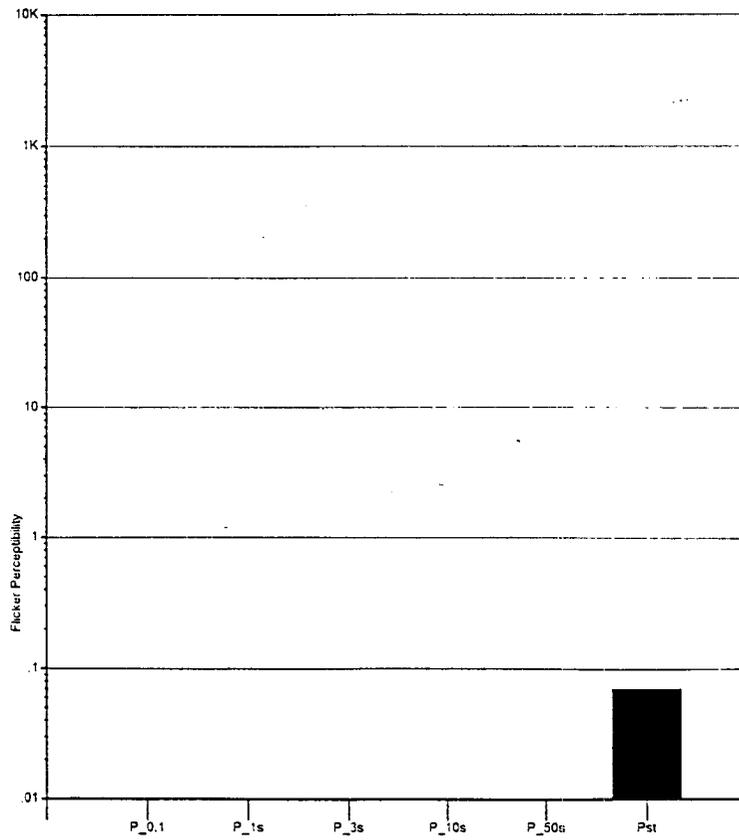
Test Engineer :

Bruce Huang

Bruce Huang

8.5.2. TEST GRAPH OF VOLTAGE FLUCTUATION AND FLICKER

Pst Histogram

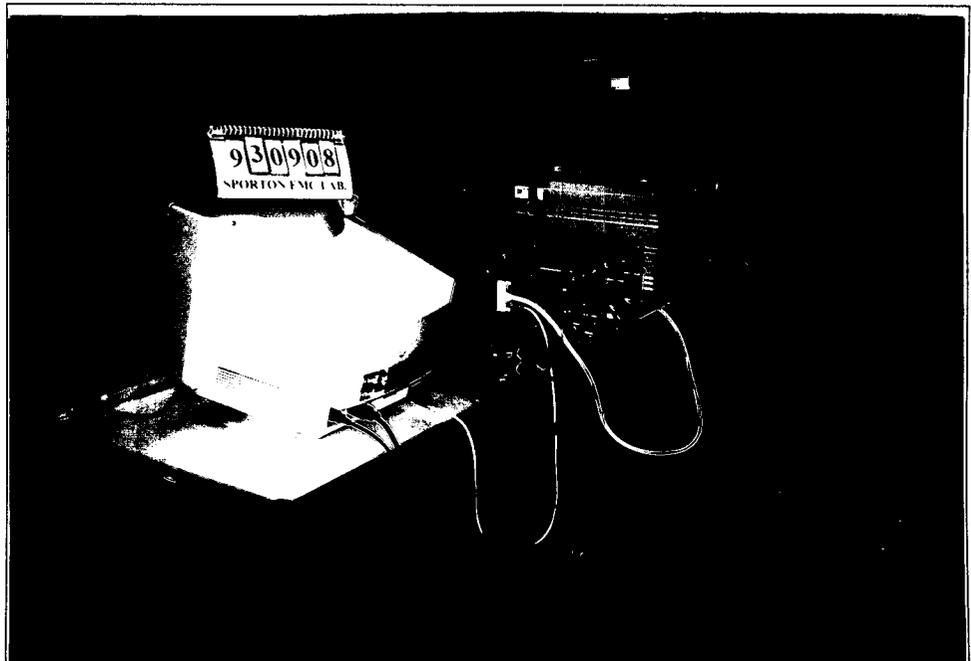


8.6. PHOTOGRAPHS OF HARMONICS TEST, VOLTAGE FLUCTUATION AND FLICKER TEST

FRONT VIEW



REAR VIEW

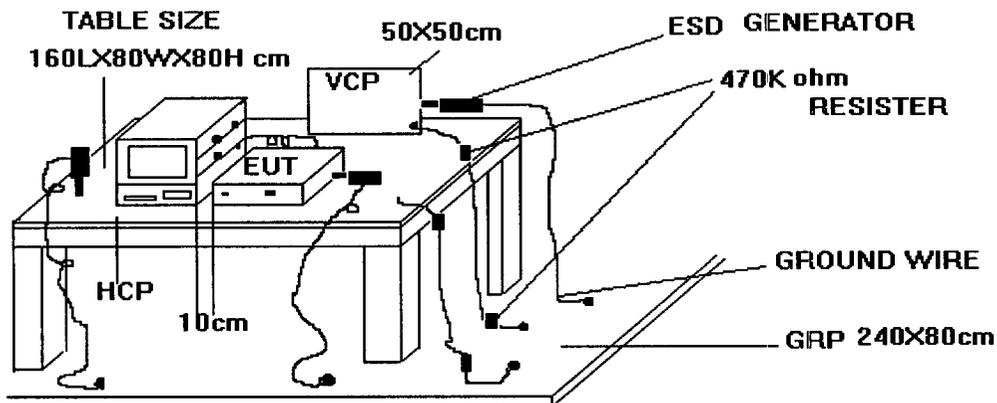


9. ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

FINAL TEST RESULT : PASS

- Basic Standard : EN 61000-4-2 (1995)
- Generic Standard : EN 50 082-2 (1995)
- Performance Criteria : B
(During testing at Contact ± 4 KV & Air discharge ± 4 KV on Case, SCSI port and power input , the EUT paused for 4~5 seconds)
- Level : 3 for Air discharge,
3 for Contact discharge
- Tested Voltage : $\pm 2 / \pm 4 / \pm 8$ KV for Air discharge,
 $\pm 2 / \pm 4 / \pm 6$ KV for Contact discharge
- Temperature : 22 °C
- Relative Humidity : 56 %
- Test Date : Mar. 22, 1999

9.1. TEST SETUP



The test setup consists of the test generator, EUT and auxiliary instrumentation necessary to perform DIRECT and INDIRECT application of discharges to the EUT as applicable, in the follow manner :

- (a) CONTACT DISCHARGE to the conductive surfaces and to coupling plane;
- (b) AIR DISCHARGE at insulating surfaces.

The preferred test method is that of type tests performed in laboratories and the only accepted method of demonstrating conformance with this standard. The EUT was arranged as closely as possible to arrangement in final installed conditions.

9.2. TEST SETUP FOR TESTS PERFORMED IN LABORATORY

A ground reference plane was provided on the floor of the test site. It was a metallic sheet (copper or aluminum) of 0.25 mm ,minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. In the SPORTON EMC LAB. we provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system.

The EUT was arranged and connected according to its functional requirements. A distance of 1m minimum was provided between the EUT and the wall of the lab. and any other metallic structure. In cases where this length exceeds the length necessary to apply the discharges to the selected points, the excess length shall , where possible, be placed non-inductively off the ground reference plane and shall not come closer than 0.2m to other conductive parts in the test setup.

Where the EUT is installed on a metal table, the table was connected to the reference plane via a cable with a 470k ohm resister located at each end, to prevent a build-up of charge. The test setup was consist a wooden table, 0.8m high, standing on the ground reference plane. A HCP, 1.6 m x 0.8 m, was placed on the table. The EUT and cables was isolated from the HCP by an insulating support 0.5 mm thick. The VCP size, 0.5 m x 0.5 m.

9.3. ESD TEST PROCEDURE

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
 - ambient temperature : 15°C to 35°C;
 - relative humidity : 30% to 60%;
 - atmospheric pressure : 68 KPa (680 mbar) to 106 KPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with single discharges. On preselected points at least ten single discharges (in the most sensitive polarity) shall be applied.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted :
 - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
 - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
 - The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT . After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

9.4. TEST SEVERITY LEVELS**9.4.1. Contact discharge**

Level	Test Voltage (KV) of Contact discharge
1	±2
2	±4
3	±6
4	±8
X	Specified

Remark : "X" is an open level.

9.4.2. Air discharge

Level	Test Voltage (KV) of Air Discharge
1	±2
2	±4
3	±8
4	±15
X	Specified

Remark : "X" is an open level.

9.5. TEST POINTS

8.5.1. TEST RESULT OF AIR DISCHARGE

TEST POINT	VOLTAGE	TESTED NO.	OBSERVATION	RESULT
CASE	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS
SCREW	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS
BRACKET	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS
FAN	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS
LED	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS
POWER SWITCH	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS
RESET SWITCH	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS
POWER INPUT	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS
SCSI PORT	±2 / ±4 / ±8 KV	BY 10	NORMAL	PASS

9.5.2. TEST RESULT OF CONTACT DISCHARGE

POLARITY	VOLTAGE	TESTED NO.	OBSERVATION	RESULT
HORIZONTAL(AT FRONT)	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
HORIZONTAL (AT LEFT)	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
HORIZONTAL (AT RIGHT)	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
HORIZONTAL (AT REAR)	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
VERTICAL (AT FRONT)	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
VERTICAL (AT LEFT)	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
VERTICAL (AT RIGHT)	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
VERTICAL (AT REAR)	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
CASE	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
SCREW	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
BRACKET	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS
SCSI PORT	$\pm 2 / \pm 4 / \pm 6$ KV	BY 10	NORMAL	PASS

Test Engineer :

Bruce Huang

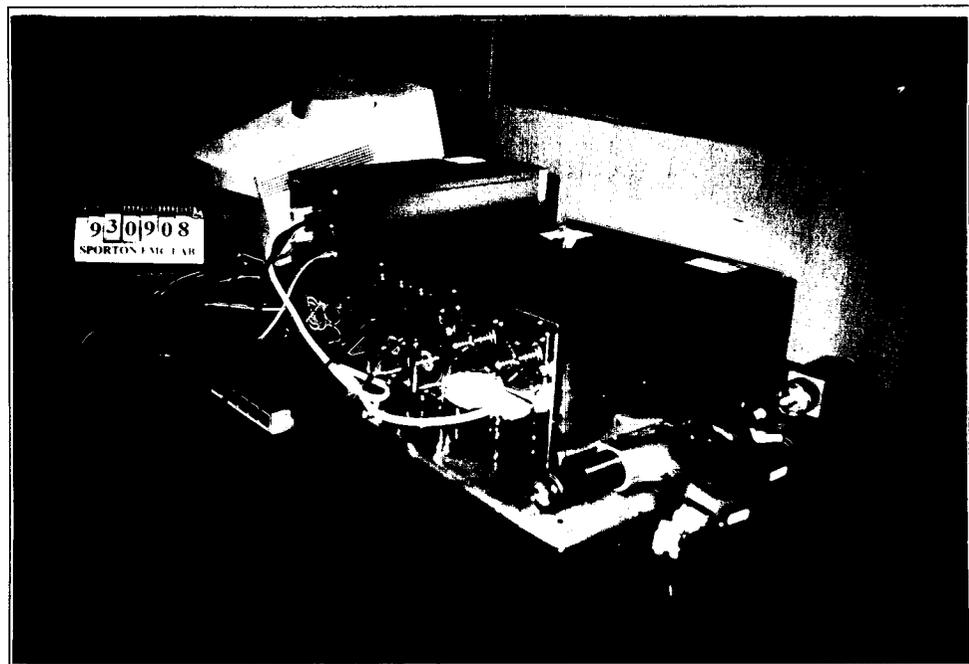
 Bruce Huang

9.6. PHOTOGRAPHS OF ELECTROSTATIC DISCHARGE IMMUNITY TEST

FRONT VIEW



REAR VIEW

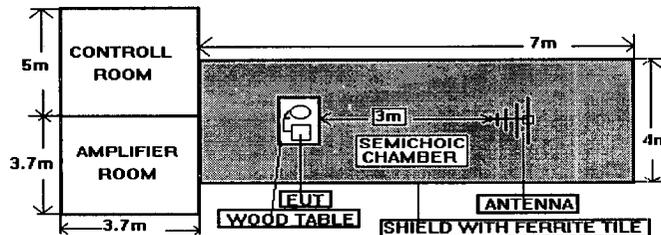


10. RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

FINAL TEST RESULT : PASS

- Basic Standard : ENV 50140 (1995)
- Generic Standard : EN 50 082-2 (1995)
- Performance Criteria : A
- Level : 3
- Frequency Range : 80 to 1000 MHz
- Field Strength : 10 V/m (Modulated 80 % AM)
- Temperature : 21°C
- Relative Humidity : 57 %
- Test Date : March 22, 1999

10.1. TEST SETUP



NOTE : The SPORTON 7m x 4m x 4m semichoic chamber is compliance with the sixteen points uniform field requirement as stated in IEC 1000-4-3 Section 6.2

The procedure defined in this part requires the generation of electromagnetic fields within which the test sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semichoic chamber.

10.2. TEST PROCEDURE

- a. The equipment to be tested is placed in the center of the enclosure on a wooden table. The equipment is then connected to power and signal leads according to pertinent installation instructions.
- b. The bilog antenna which is enabling the complete frequency range of 80 MHz to 1000 MHz is placed 3m away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the applicable antennae.
- c. The test is normally performed with the antenna facing the most sensitive side of the EUT. The polarization of the field generated by the biconical antenna necessitates testing each position twice, once with the antenna positioned vertically and again with the antenna positioned horizontally. The circular polarization of the field from the log-spiral antenna makes a change of position of the antenna unnecessary.
- d. At each of the above conditions, the frequency range is swept from 80 MHz to 1000 MHz, pausing to adjust the R.F. signal level or to switch oscillators and antenna. The rate of sweep is in the order of $1.5 * 10^{-3}$ decades/s. The sensitive frequencies or frequencies of dominant interest may be discretely analyzed.

10.3. TEST SEVERITY LEVELS

Frequency Band : 80 MHz to 1000 MHz

Level	Test field strength (V/m)
1	1
2	3
3	10
X	Specified

Remark : "X" is an open class.

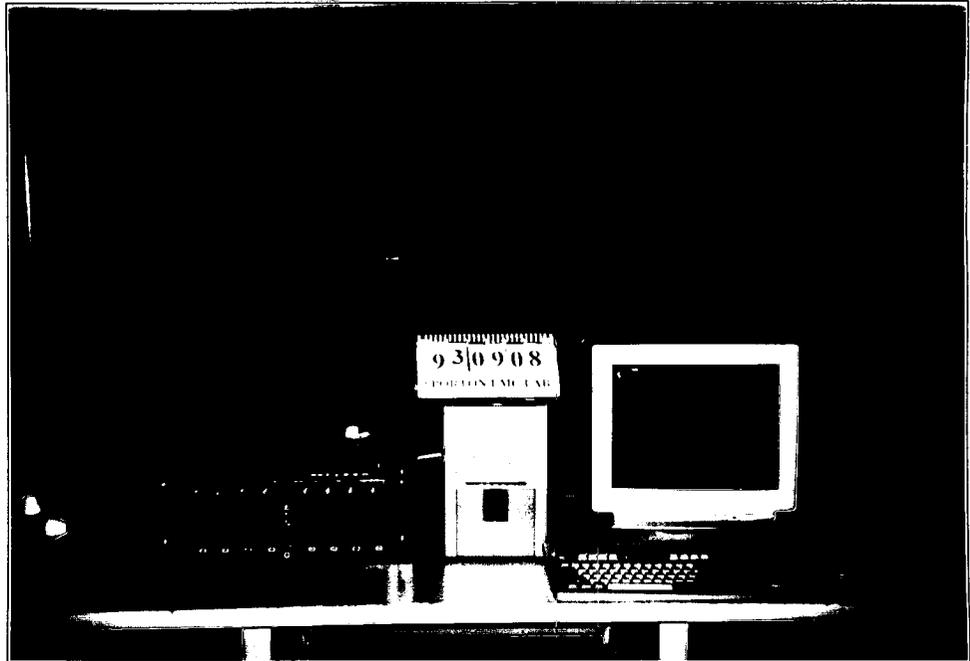
Test Engineer :

Bruce Huang

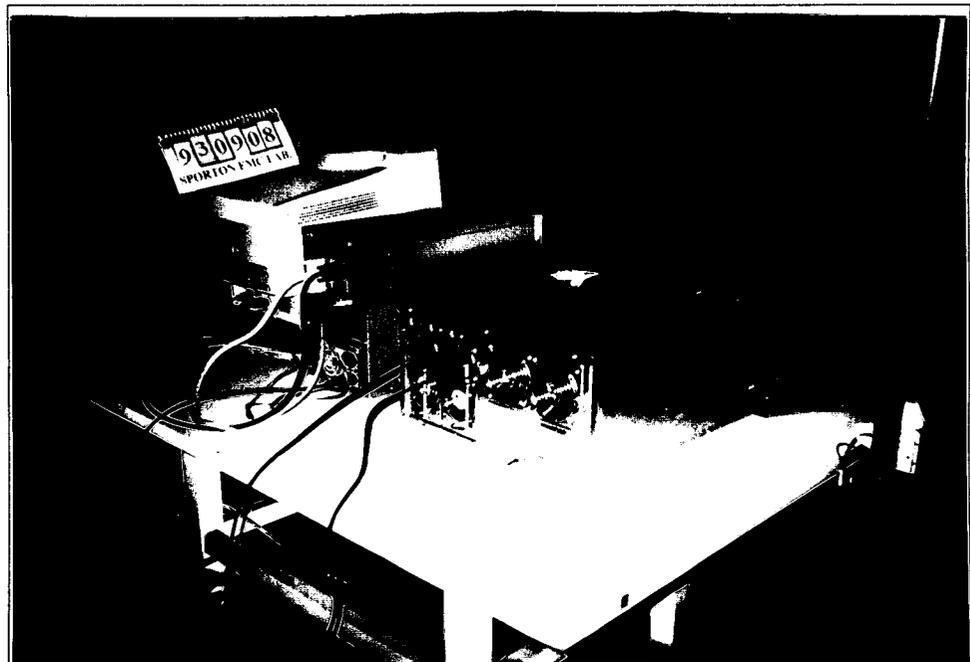
Bruce Huang

10.4. PHOTO OF RADIO FREQUENCY ELECTROMAGNETIC FIELD IMMUNITY TEST

FRONT VIEW



REAR VIEW

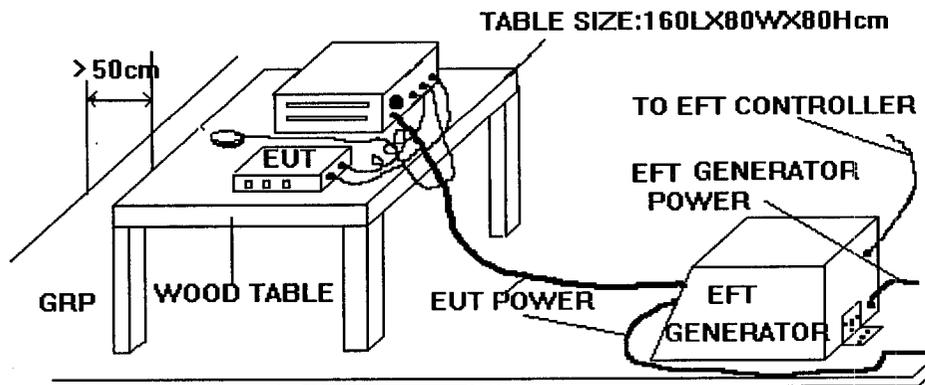


11. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT/BURST)

FINAL TEST RESULT : PASS

- Basic Standard : EN 61000-4-4 (1995)
- Generic Standard : EN 50 082-2 (1995)
- Performance Criteria : B
(During testing at ± 1 KV, the EUT copy program paused for seconds)
- Level : on Power Supply -- 2
Test Voltage : on Power Supply -- $\pm 0.5 / \pm 1.0$ KV
- Temperature : 24 °C
- Relative Humidity : 54 %
- Test Date : March 22, 1999

11.1. TEST SETUP



The EUT was placed on a ground reference plane and was insulated from it by an insulating support about 0.1m thick. If the EUT is table-top equipment, it was located approximately 0.8m above the GRP.. The GRP. was a metallic sheet (copper or aluminum) of 0.25 mm ,minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. It shall project beyond the EUT by at least 0.1m on all sides and connected to the protective earth. In the SPORTON EMC LAB. we provided 1 mm thickness aluminum ground reference plane or 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is 1 m x 1 m, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system. The EUT was arranged and connected according to its functional requirements. The minimum distance between the EUT and other conductive structures, except the GRP. beneath the EUT, was more than 0.5 m. Using the coupling clamp, the minimum distance between the coupling plates and all other conductive structures, except the GRP. beneath the EUT, was more than 0.5 m. The length of the signal and power lines between the coupling device and the EUT was 1m or less.

11.2. TEST ON POWER LINE

- a. The EFT/B-generator was located on the GRP.. The length from the EFT/B-generator to the EUT as not exceed 1 m.
- b. The EFT/B-generator provides the ability to apply the test voltage in a non-symmetrical condition to the power supply input terminals of the EUT.

10.3. TEST ON COMMUNICATION LINES

- a. The coupling clamp is composed of a clamp unit for housing the cable (length more than 3 m), and was placed on the GRP..
- b. The coupling clamp provides the ability of coupling the fast transient/bursts to the cable under test.

11.4. TEST PROCEDURE

- a. In order to minimize the effect of environmental parameters on test results, the climatic conditions when test is carrying out shall comply with the following requirements :
 - ambient temperature : 15°C to 35°C;
 - relative humidity : 45% to 75%;
 - atmospheric pressure : 68 KPa (680 mbar) to 106 KPa (1060 mbar).

- b. In order to minimize the effect of environmental parameters on test results, the electromagnetic environment of the laboratory shall not influence the test results.

- c. The variety and diversity of equipment and systems to be tested make it difficult to establish general criteria for the evaluation of the effects of fast transients/bursts on equipment and systems.

- d. The test results may be classified on the basic of the operating conditions and the functional specification of the equipment under test, according to the following performance criteria :
 - Normal performance within the specification limits.
 - Temporary degradation or loss of function or performance which is selfrecoverable.
 - Temporary degradation or loss of function or performance which requires operator intervention or system reset.
 - Degradation or loss of function which is not recoverable due to damage of equipment (components).

11.5. TEST SEVERITY LEVELS

The following test severity levels are recommended for the fast transient/burst test :

Open circuit output test voltage $\pm 10\%$		
Level	On Power Supply	On I/O signal, data and control line
1	0.5 KV	0.25 KV
2	1.0 KV	0.50 KV
3	2.0 KV	1.00 KV
4	4.0 KV	2.00 KV
X	Specified	Specified

Remark : " X " is an open level. The level is subject to negotiation between the user and the manufacturer or is specified by the manufacturer.

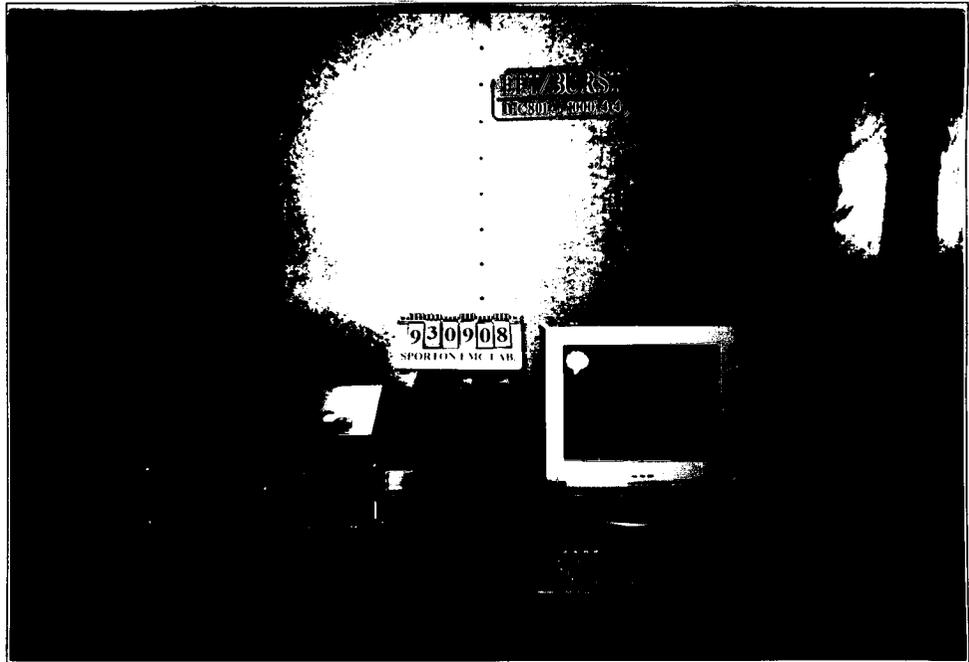
Test Engineer :

Bruce Chang

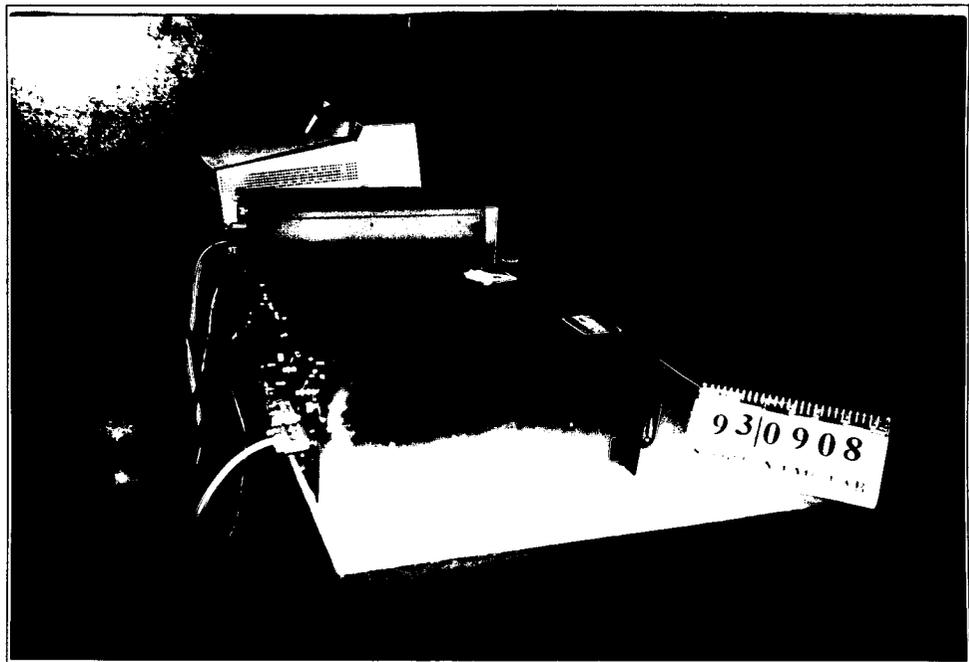
 Bruce Chang

11.6. PHOTO OF ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST

FRONT VIEW



REAR VIEW



12. SURGE IMMUNITY TEST

- **Pass** performance Criteria : **A**
- Basic Standard : EN 61000-4-5 (1995)
- Generic Standard : EN 50082-2 (1995)
- Level : 3
- Input Voltage, Frequency : AC 230V, 50Hz
- Test Voltage : 1.0 KV, 2.0 KV
- Test Mode : Read, Copy
- Temperature : 24 ° C
- Relative Humidity : 54 %
- Test Date : March 22, 1999

12.1. TEST RECORD

Voltage (KV)	Test Poing	Polarity	Phase Angle				Result
			0°	90°	180°	270°	
1	L - N	+	A	A	A	A	<u>PASS</u>
		-	A	A	A	A	<u>PASS</u>
2	L - PE	+	A	A	A	A	<u>PASS</u>
		-	A	A	A	A	<u>PASS</u>
	N - PE	+	A	A	A	A	<u>PASS</u>
		-	A	A	A	A	<u>PASS</u>

12.2. TEST LEVEL

Level	Open-circuit test voltage, $\pm 10\%$, KV
1	0.5
2	1.0
3	2.0
4	4.0
x	Specified

NOTE - x is an open class.
This level can be specified in the product specification.

12.3. TEST PROCEDURE

a. Climatic conditions

The climatic conditions shall comply with the following requirements :

- ambient temperature : 15 °C to 35 °C
- relative humidity : 10 % to 75 %
- atmospheric pressure : 86 kPa to 106 kPa (860 mbar to 1060 mbar)

b. Electromagnetic conditions

The electromagnetic environment of the laboratory shall not influence the test results.

c. The test shall be performed according the test plan that shall specify the test set-up with

- generator and other equipment utilized;
- test level (voltage/current);
- generator source impedance;
- internal or external generator trigger;
- number of tests : at least five positive and five negative at the selected points;
- repetition rate : maximum 1/min.
- inputs and outputs to be tested;
- representative operating conditions of the EUT;
- sequence of application of the surge to the circuit;
- phase angle in the case of a.c. power supply;



- actual installation conditions, for example :
 - AC : neutral earthed,
 - DC : (+) or (-) earthed to simulated the actual earthing conditions.

- d. If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the a.c. voltage wave (positive and negative).

- e. The surges have to be applied line to line and line(s) and earth. When testing line to earth, the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.

- f. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan.

- g. All lower levels including the selected test level shall be satisfied. For testing the secondary protection, the output voltage of the generator shall be increased up to the worstcase voltage breakdown level (let-through level) of the primary protection.

- h. If the actual operating signal sources are not available, they may be simulated. Under no circumstances may the test level exceed the product specification. The test shall be carried out according to the test plan.

- i. To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied. For acceptance test a previously unstressed equipment shall be used to the protection devices shall be replaced.

13. CONDUCTED DISTURBANCES INDUCED BY RADIO-FREQUENCY FIELD IMMUNITY TEST (CS)

- **Pass** performance Criteria : **A**
- Basic Standard : ENV 50141 (1993)
- Generic Standard : EN 50082-2 (1995)
- Input Voltage, Frequency : AC 230V, 50Hz
- Level : 2
- Test Voltage : 3 V/m (Modulated 80 % AM)
- Frequency Range : 0.15 MHz to 80 MHz
- Temperature : 18 ° C
- Relative Humidity : 71 %
- Test Date : March 23, 1999

13.1. TEST LEVEL

Level	Voltage Level (EMF),
1	1 V
2	3 V
3	10 V
x	Specified
<p>NOTE - x is an open class. This level can be specified in the product specification.</p>	

13.2. TEST PROCEDURE

- a. The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- b. This test method test can be performed without using a sell shielded enclosure. This is because the disturbance levels applied and the geometry of the setups are not likely to radiated a high amount of energy, especially at the lower frequencies. If under certain circumstances the radiated energy is too high, a shielded enclosure has to be used.

- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- d. Filters shall be used to prevent (higher order or sub-) harmonics from disturbing the EUT. A High-Pass Filter. 100KHz, (HPF) may be required with the test generator. The band stop characteristics of the Low-Pass Filters (LPF) shall be sufficient to suppress the harmonics down to the immunity level required within that band. These filters shall be inserted with the test generator before setting the test level.
- e. The frequency range is swept from 150 KHz to 230 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1KHz sinewave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed 1.5×10^{-3} decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- f. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency(ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- g. An alternative test procedure may be adopted, wherein the frequency range is swept incrementally, with a step size not exceeding 4% of the start ad thereafter 4% of the preceding frequency value. The test level should be at least twice the value of the specified test level.
- h. In cases of dispute, the test procedure using a step size not exceeding 1% of the start and thereafter 1% of preceding frequency value shall take precedence.
- i. Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.
- j. The use of special exercising programs is recommended.
- k. Testing shall be performed according to a Test Plan, which shall be included in the test report.
- l. It may be necessary to carry out some investigatory testing in order to establish some aspects of the test plan.

14. Voltage Dips, short interruptions and voltage variations immunity tests

- **Pass** performance Criteria : **A**
- Basic Standard : EN 61000-4-11 (1994)
- Generic Standard : EN 50082-2 (1995)
- Input Voltage, Frequency : AC 230V, 50Hz
- Test Mode : Read, Copy
- Temperature : 23 °C
- Relative Humidity : 55 %
- Test Date : March 22, 1999

14.1. TEST RECORD OF VOLTAGE INTERRUPTION

Voltage (V)	Phase Angle								% Reduction	ms
	0 °	45 °	90 °	135 °	180 °	225 °	270 °	315 °		
230	B	B	B	B	B	B	B	B	> 95 %	5000

14.2. TEST RECORD OF VOLTAGE DIPS

Voltage (V)	Phase Angle								% Reduction	ms
	0 °	45 °	90 °	135 °	180 °	225 °	270 °	315 °		
230	A	A	A	A	A	A	A	A	30	500
230	A	A	A	A	A	A	A	A	60	500

14.3. TESTING REQUIREMENT AND PROCEDURE :

The test was based on EN 61000-4-11 (1994) and EN50082-2 (1995).

14.4. Information of cables :

Power cable : unshielded power cable.

14.5. Test conditions :

1. Source voltage and frequency : 230V / 50Hz, Single phase.
2. Phase shifting : 0, 45, 90, 135, 180, 225, 270, 315 degrees.
3. Test of interval : 10 sec.
4. Level and duration : Sequency of 3 dips/interrupts.
5. Voltage rise (and fall) time : 1 ~ 5 μ s.
6. Test severity :

Voltage dip and Interrupt reduction (%)	Test Duration (ms)
30	500
60	100
100	10
100	80
100	5000

15. LIST OF MEASURING EQUIPMENT USED

[CE-EMI]

Instrument	Manufacturer	Model No.	Serial No.	Characteristics	Calibration Date	Remark
EMC Receiver (site 1)	HP	8591EM	3536A00673	9 KHz - 1.8 GHz	Aug. 27, 1998	Conduction
LISN (site 1)	EMCO	3850/2	9510-1035	50 ohm / 50 uH	Oct. 23, 1998	Conduction
LISN (site 1)	KYORITSU	KNW-47	8-693-10	50 ohm / 50 uH	Oct. 23, 1998	Conduction
EMI Filter (site 1)	CORCOM	MRI-2030	N/A	480 VAC / 30 A	N/A	Conduction
Quasi-peak Adapter (site 3)	HP	85650A	2811A01116	9KHz -1 GHz	Jul. 19, 1998	Radiation
Amplifier (Site 3)	HP	8447D	2944A09068	0.1MHz -1.3GHz	Aug. 27, 1998	Radiation
Spectrum Analyzer (site 3)	HP	8568B	2732A04100	100Hz - 1.5GHz	July 19, 1998	Radiation
Bilog Antenna (Site 3)	CHASE	CBL6112A	2320	30MHz -2GHz	Sep. 10, 1998	Radiation
Half-wave dipole antenna (Site 3)	EMCO	3121C	9705-1285	28 M - 1GHz	May 19, 1998	Radiation
Turn Table (site 3)	EMCO	2080	9711-2022	0 ~ 360 degree	N/A	Radiation
Antenna Mast (site 3)	EMCO	2075	9710-2101	1 m- 4 m	N/A	Radiation

[CE-EMS]

Instrument	Manufacturer	Model No.	Characteristics	Calibration Date	Remark
ESD Simulator	KEYTEK	DN-10	N/A	March 27, 1999	ESD
ESD Simulator	KEYTEK	ESD-1	0 KV - 25 KV	March 27, 1999	ESD
Amplifier	AR	100W 1000M3	80 MHz - 1 GHz	N/A	RS
Isotropic Field Probe	AR	FP3000A	10 KHz - 1 GHz	Jun. 20, 1998	RS
IEEE-488 Interface	AR	CP3000	N/A	N/A	RS
System Interface	EMC Automation	200	HP-IB INTERFACE	N/A	RS
Power Meter	EMC Automation	438A	100 KHz -4.2 GHz	N/A	RS
Video Camera controller	EMC Automation	VCC-01	N/A	N/A	RS
Signal Generator	HP	8648A	100 KHz - 1 GHz	Sep. 11, 1998	RS
Signal Generator	R&S	SMX	100 KHz - 1 GHz	Nov. 08, 1997	RS
Antenna	CHASE	CBL6121A	26 MHz - 1 GHz	Jun. 14, 1998	RS
Amplifier	AR	75W 75A220	25MHz - 300MHz	Jun. 14, 1998	RS
EFT Generator	KEYTEK	CE-40	0 KV - 4.4 KV	July 10, 1998	EFT
Harmonic/Flicker Test System	HP	6843A	4800VA 90A / 48A PEAK	Nov. 15, 1997	Harmonics, Flicker
EMC Immunity Tester	EMC PARTNER AG Switzerland	TRANSIENT 1000	0 ~ 260 rms, 16A	Feb. 02, 1999	DIP
Surge Coupler/ Decoupler	MIG	MIG0603-IN 2	6KV - 3KV	Feb. 02, 1999	SURGE

16. DECLARATION OF CONFORMITY AND THE CE MARK

There are three possible procedures pertaining to the declaration of conformity :

16.1. Conformity testing and declaration of conformity by the manufacturer or his authorized representative established within the Community or by an importer.

- Article 10 (1) of the EMC Directive,
- § 3 (1) no. 2a of the EMC Act.

16.2. Declaration of conformity issued by the manufacturer or his authorized representative established within the Community or by an importer following testing of the product and issued of an *EC certificate of conformity by a competent body.*

- Article 10 (2) of the EMC Directive,
- § 3 (1) no. 2b of the EMC Act.

16.3. Declaration of conformity issued by the manufacturer or his authorized representative established within the Community or by an importer following *testing and certification of the product by a notified body.*

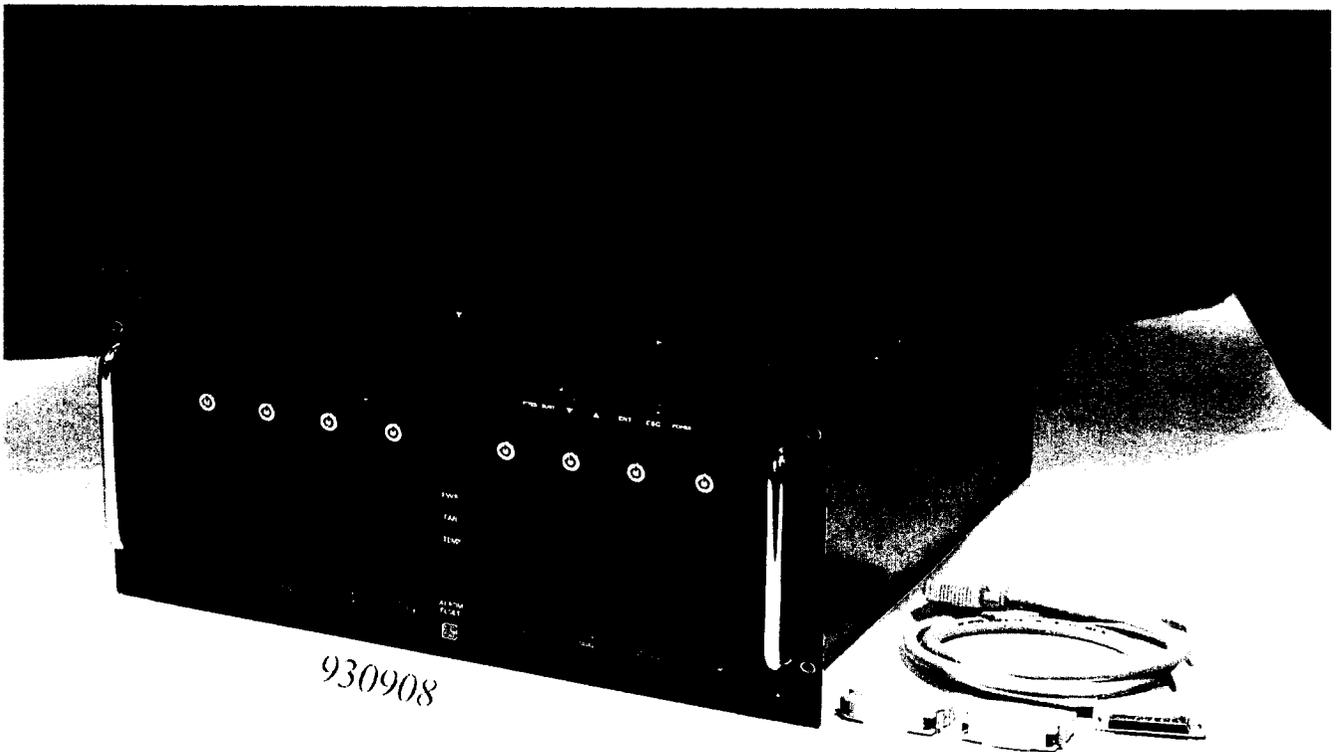
- Article 10 (5) of the EMC Directive,
- § 3 (1) no. 2b of the EMC Act (radio transmitting installations).

16.4. Specimen For The CE Marking Of Electrical / Electronical Equipment

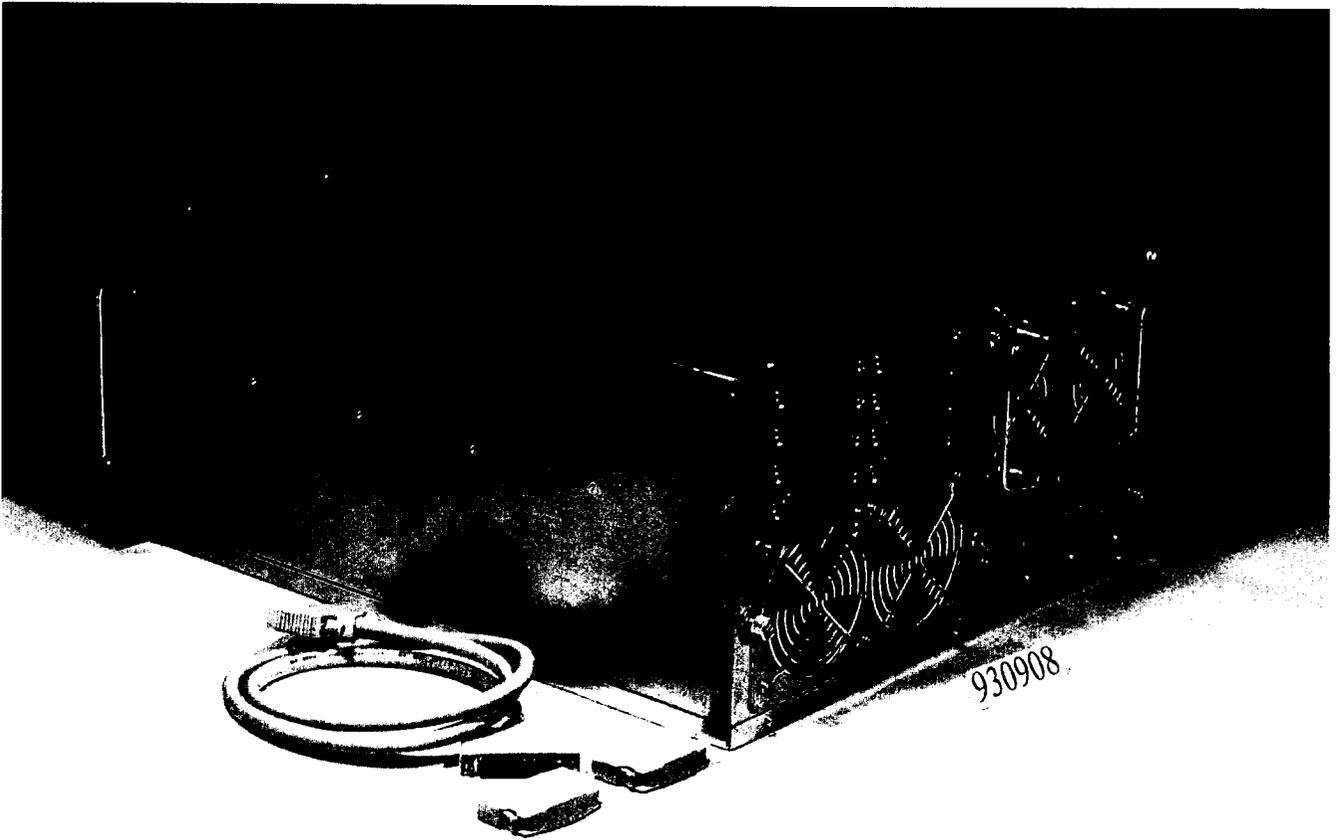
The components of the CE marking shall have substantially the same vertical dimension, which may not be less than 5 mm.



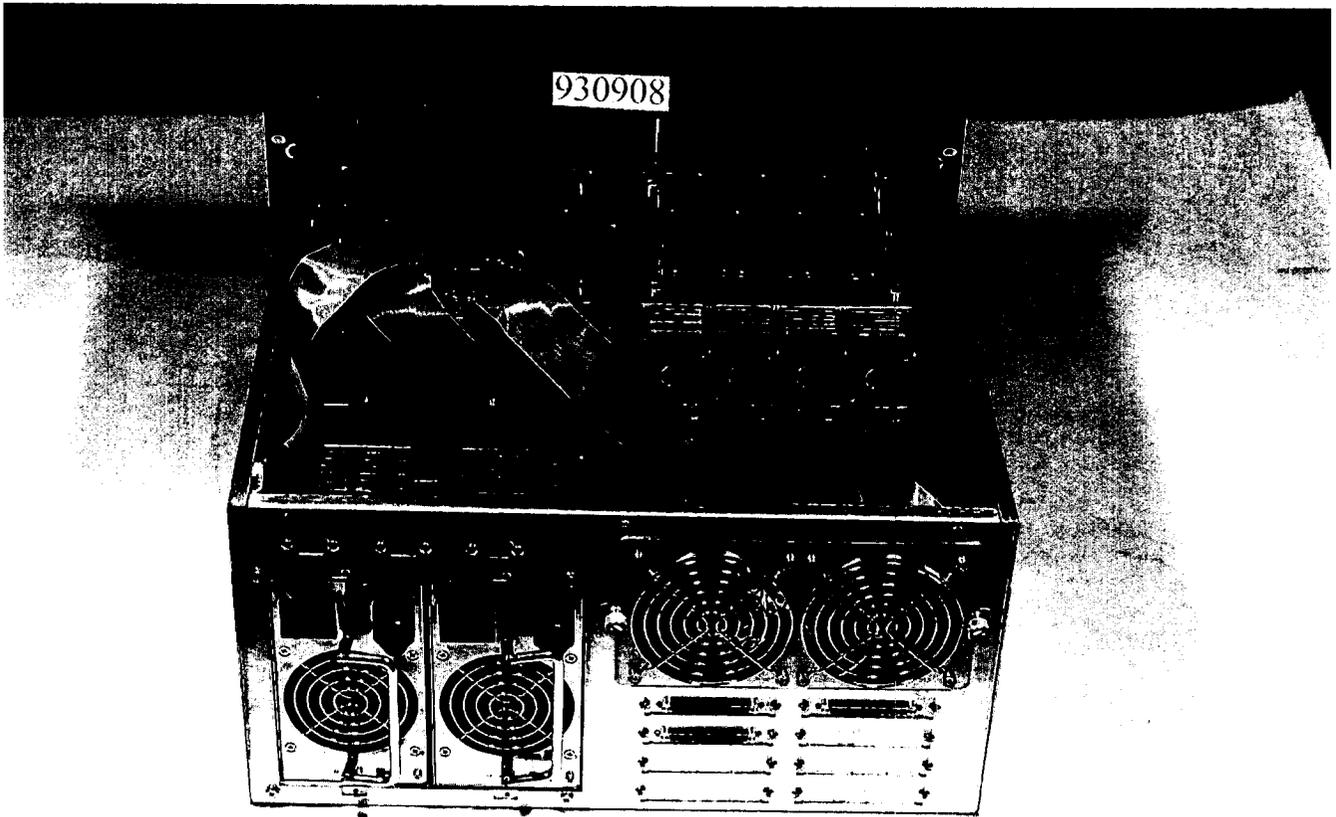
APPENDIX A. Photographs of EUT



930908-1.JPG

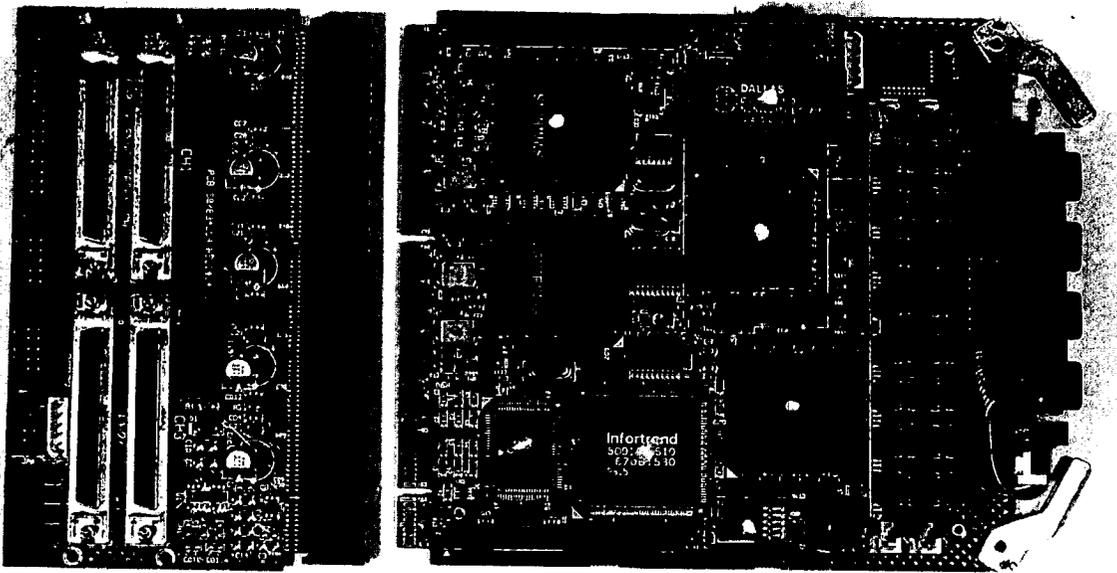


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930908-3.JPG

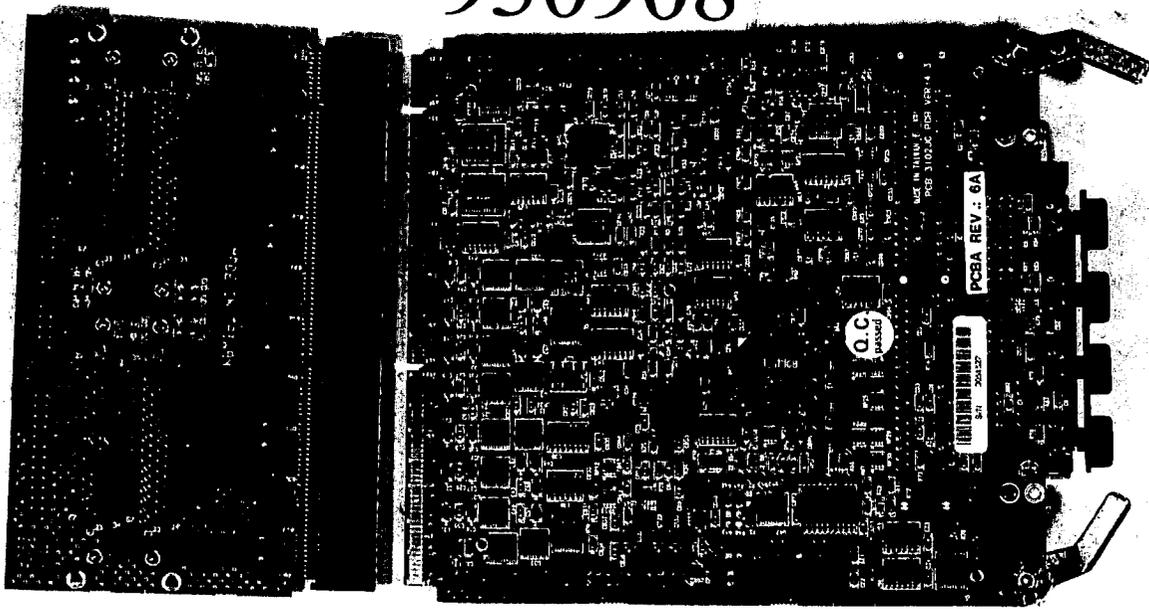
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